



Measured Characteristics of Selected *S*-Band Coaxial-to-Waveguide Adaptors

by William O. Coburn

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Sensors and Electron Devices Directorate, ARL

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14. ABSTRACT <p>A design procedure for a leaky wave antenna fabricated in slitted waveguide was developed based on the analysis of Goldstone and Oliner (<i>J</i>). The use of dielectric loading in slitted rectangular or dual-ridged waveguide is one way to influence the antenna performance. An experimental fixture to evaluate the transmission line characteristics of miniaturized dual-ridged waveguide was fabricated to allow for dielectric loading in the ridge section. The goal is to obtain experimental validation of the theory as applied to a specific leaky dual-ridged waveguide loaded with conventional engineering plastics. As a first step the effect of the coaxial-to-waveguide adaptors needed to feed and terminate the experimental fixture must be determined. The offset short method is used to characterize commercial microwave adaptors requiring at least three different waveguide lengths. Five different lengths of S-Band waveguide sections were available although some choices are more appropriate than others depending on the frequency range of interest. The experimental results are used to calculate the scattering parameters for five different microwave adaptors over the frequency range 2.8 to 3.2 GHz. The method and the limitations imposed by not being able to use optimized waveguide lengths are described. A summary of the adaptor characteristics is provided for the reference of other researchers so that the most appropriate part can be chosen for a given application.</p>					
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The author acknowledges the assistance of Tim White in the accurate measurement of the waveguide lengths. His expertise in this measurement was critical to successfully implementing the experimental method.

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1. Purpose

The physical structure of interest is a leaky waveguide, excited by a transverse electric (TE)₁₀-mode (or H₁₀-mode), with a long slit in the waveguide narrow-wall radiating into a half-space (i.e., an infinite flange approximation). The leaky wave antenna design procedure of Oliner (1) can be extended through an iterative procedure (2) and applied to the case of an asymmetric dual-ridged waveguide with variable width slit and dielectric filled ridge section (3). Based on this design procedure, an asymmetric dual-ridged waveguide was fabricated that allows for removable dielectric inserts in the ridge section. This dielectric-loaded dual-ridged waveguide is connected to S-Band (WR-284) coaxial-to-waveguide adaptors for measurement purposes. An impedance matching transition to rectangular waveguide was not attempted because the leaky waveguide would be fed as part of an element in an antenna array. In order to evaluate the closed waveguide the WR-284 microwave, adaptors must be characterized over the frequency range of interest, 2.8 to 3.2 GHz. The offset short experimental method is used with different lengths of bolted waveguide sections between the adaptor and shorting plate (4). The next step is to use the known adaptors to measure the transmission line characteristics and the antenna pattern obtained for the leaky dual-ridged waveguide experimental fixture.

2. Background

A dual-ridged waveguide is a rectangular waveguide with a centered rectangular ridge on both of its wide sides as shown in figure 1 (a) for the symmetric case. The structure requires determination of the guide wavelength

$$\lambda_g = \frac{\lambda}{\sqrt{1 - \left(\frac{\lambda}{\lambda_c}\right)^2}} \quad (1)$$

since for the ridged waveguide the cutoff wavelength, λ_c is not simply related to the guide width, a . The transverse (to y) wavenumber is $k_z = 2\pi/\lambda_c$, for the cutoff wavelength of each mode. The transverse resonance method provides the correct λ_c for each mode to satisfy the boundary conditions throughout the waveguide. Following Marcuvitz, the dominant mode propagation in an equivalent transverse network can be extended to the case of uniform dielectric loading in the ridged section (5). A solution for the propagation constant of leaky, dielectric-loaded, dual-ridged waveguide using the perturbation technique can be used to calculate the radiation pattern for different slit width profiles. But this analysis does not include the effect of microwave adaptors to feed and/or terminate the leaky waveguide.

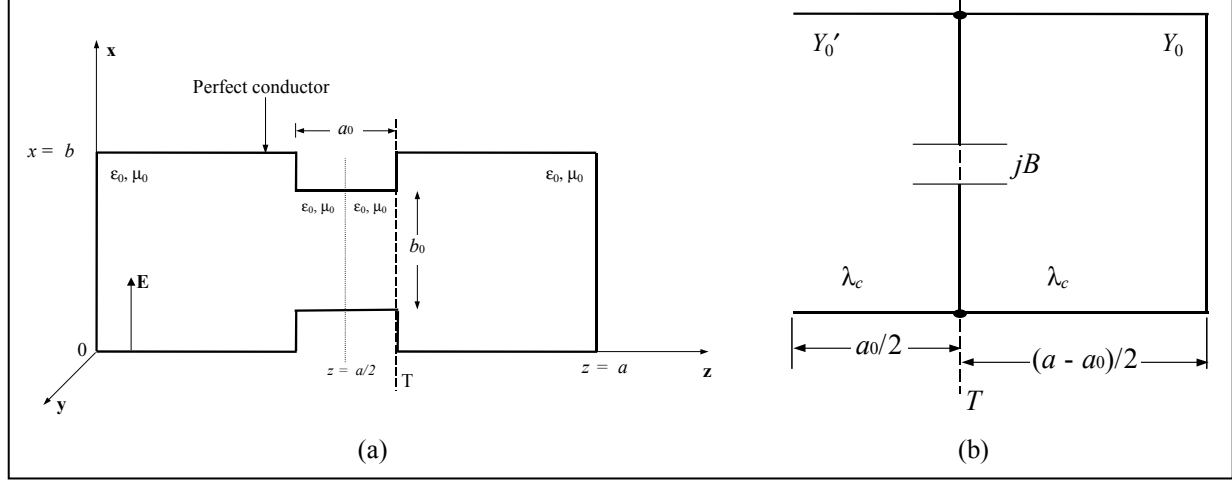


Figure 1. (a) The cross section of an air-filled, symmetric, dual-ridged waveguide. (b) An approximate equivalent circuit for an air-filled, symmetric, dual-ridged waveguide.

The dual-ridged leaky waveguide with uniform dielectric loading in the ridge section has some advantages for use in antenna arrays where feed systems can be carefully designed for optimum performance. At this stage, experimental data on a single leaky waveguide is required but limited by available microwave components and test equipment. A center operating frequency of $f_0 = 3$ GHz is chosen so that the experimental fixture would have physical dimensions that could be accurately fabricated. The fixture is designed to allow different dielectric loading and uses WR-284 rectangular flanges to allow connection to standard S -Band waveguide components. The parameters of the experimental fixture are the waveguide width, a , height, b and the ridge width, a_0 and height b_0 . The waveguide height is symmetric but the width has asymmetry $w' = A_2/A_1 = 1.2$, as shown in figure 2. A normalized ridge width, $r = a_0/a = 0.05$, and normalized ridge height, $r' = b_0/b = 0.5$, were chosen in the design procedure. The parameter $b_1/A_1 = 0.5$ so that $b/a = 0.216$ corresponds to roughly quarter-height waveguide (see figure 2). Fabrication is accomplished using soldered brass sheet stock (80-mils thick) with an axial flange holding the ridge sections having 1.5-in bolt spacing to allow disassembly. The normalized length is designed to be $k_0L = 20\pi$ for free space wavenumber k_0 , corresponding to ten wavelengths at the center frequency. The ridge section can be filled with different plastic inserts which have a machined groove to mate with the ridge section of the experimental fixture as shown in figure 2.

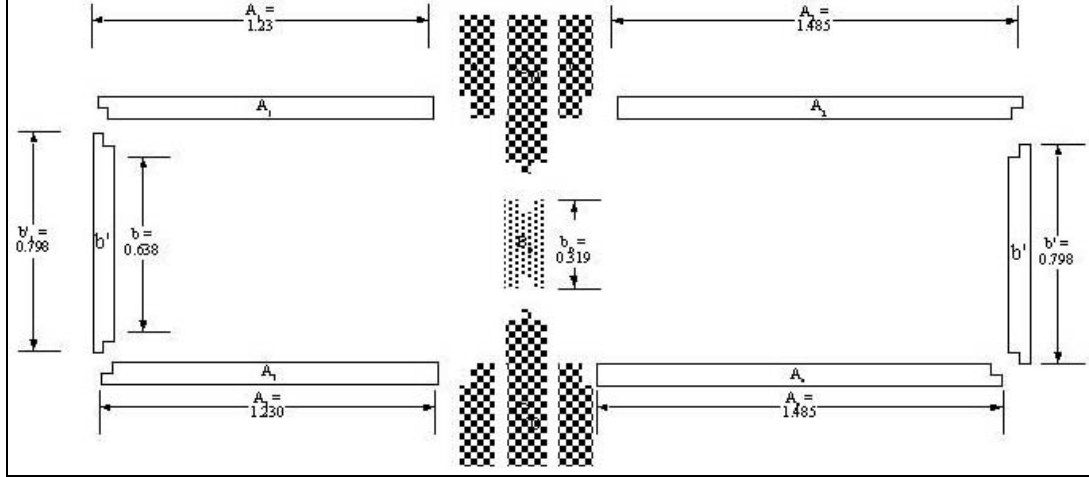


Figure 2. A scale drawing of the dual-ridged waveguide cross-section with removable dielectric filled center section and bolted axial flange.

The dielectric and conductor losses are calculated as independent loss mechanisms but for typical materials these losses are negligible. The *S*-Band adaptors are characterized by their scattering (*S*-) parameters which relate the two incident, [*u*], and reflected, [*v*], voltage waves at reference planes 1 and 2 by the scattering matrix [*v*] = [*S*] [*u*]. The leaky waveguide continuously loses energy along its length due to radiation so that a matched termination is not critical for performance. The impedance mismatch to the feed waveguide would then determine the input reflection coefficient, Γ , and transmission coefficient, *T*, where in terms of the *S*-parameters, $\Gamma = S_{11}$ and $T = S_{21}$ for matched termination. Performance is often characterized by the return loss (RL) and insertion loss (IL), or alternatively by the input standing wave ratio (SWR). These parameters are related by

$$RL = 20 \log |\Gamma|, \quad IL = 20 \log |T|, \quad SWR = \frac{1 + |\Gamma|}{1 - |\Gamma|} \quad (2)$$

This fixture includes WR-284 rectangular cover flanges for bolted connection to the input (feed) and output (termination) waveguide. Several coaxial-to-waveguide adaptors are available from Narda¹ (Model 614A), Hewlett-Packard² (Model S281A) and MicroLab/FXR³ (Models S601A, S601B and S601C). Many of these parts are no longer in production and the specifications are not readily available. Also, some damage was observed on all these parts so the actual performance may not meet the original specifications and must be measured. Typical specifications are SWR < 1.4 over the range 2.6 to 3.95 GHz corresponding to RL < -15 dB. These adaptors have Type-N Female coaxial inputs and WR-284 circular cover flanges as shown in figure 3. Short WR-284 waveguide extensions are used as needed to convert circular flanges to standard rectangular cover flanges as indicated in the block diagram shown in figure 4.

¹ Narda Microwave Group, L3 Communications, New York, NY.

² Hewlett-Packard USA, Palo Alto, CA.

³ F-R Machine Works, Inc., Electronics and X-Ray Division, Queens, NY.

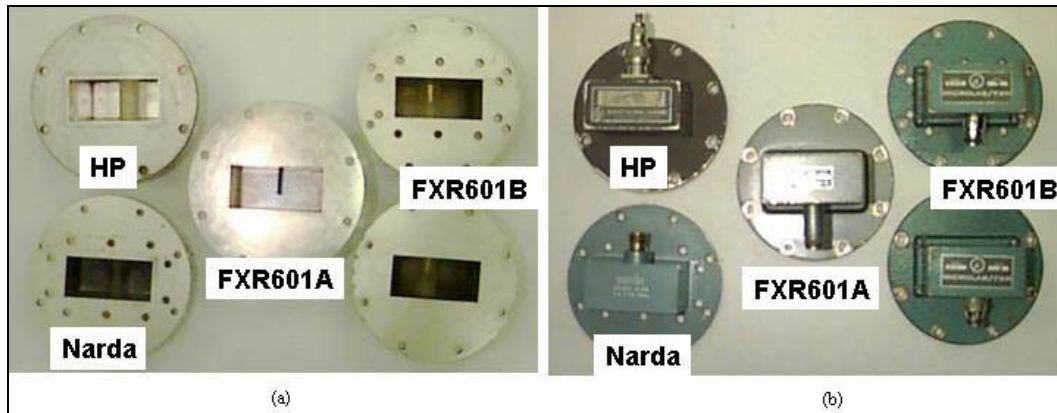


Figure 3. Photograph of WR-284 microwave adaptors. (a) View of coaxial probe. (b) View of coaxial input.

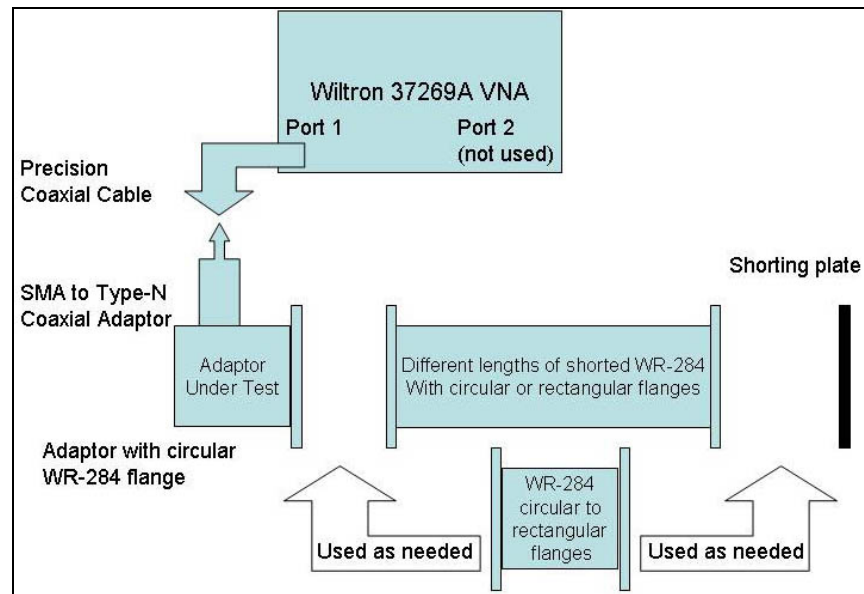


Figure 4. Block diagram of the WR-284 microwave adaptor experimental arrangement.

Waveguide sections with circular flanges were primarily used with a circular to rectangular flange extension for connection to the rectangular shorting plate. One section of WR-284 with rectangular flanges was also used, where an extension is inserted between the circular flanged adaptor and the rectangular flanged waveguide. The Type-N coaxial input was adapted to an SMA connector using the same part for all the adaptors (shown mounted to the HP adaptor in figure 3). The measured data was obtained with a Wiltron⁴ 37269A vector network analyzer (VNA), calibrated for input reflection measurements using the Wiltron K-Cal Kit Model 3652. These S-Band microwave adaptors all have dielectric sheathed coaxial probe designs except the FXR Model S601A (S/N 154) which does not use a dielectric coating (see figure 3).

⁴ Wiltron Company, Morgan Hill, CA.

3. Experimental Method

The offset short method with different lengths of WR-284 waveguide is used to calculate the S -parameters of the adaptor from the measured input reflection coefficients. A sliding short in WR-284 would be preferred, but was not available, so sections of bolted waveguide are used. A flat shorting plate is placed at the end of the fixed lengths of WR-284 that are available for use in this experiment. Since the input impedance for ideal short-circuit terminations are known, then measurements on uniform lengths of transmission line can be combined to calculate the complex S -parameters (6). The input reflection coefficient for five different lengths to the shorting plate was measured over the frequency range 2.8 to 3.2 GHz. The incident and reflected voltage waves at ports 1 and 2 are related by $[S]$, so the reflection coefficient at the input port, ρ_i , can be written in terms of the reflection coefficient at the output port, ρ_L . For each independent ρ_L (defined looking toward the termination) the corresponding input reflection coefficient is

$$\rho_i = S_{11} - \frac{S_{12}S_{21}}{S_{22} - 1/\rho_L} \quad (3)$$

By assuming reciprocity ($S_{12} = S_{21}$), three measurements of ρ_i corresponding to known values of ρ_L are needed to solve for all the S -parameters. Neglecting losses, a reference length of waveguide to the shorting plate at port 2 have reflection coefficient $\rho_{L0} = -1$. Then, when the termination is shifted with longer waveguide sections, the corresponding input reflection is $\rho_{Ln} = -e^{-j\phi_n}$, where $\phi_n = 2\beta\Delta L_n$ is the phase of ρ_{Ln} with respect to the original reference plane. The phase propagation constant, β , depends on the guide width, $a = 2.84$ -in for WR-284 half-height waveguide. Here ΔL_n is the additional length to the shorting plate from a reference measurement on length L_0 , or $\Delta L_n = L_i - L_0$ ($n = 1, 2$) for different waveguide sections having total length L_i to the shorting plate. Solving for the S -parameters leads to

$$S_{11} = \frac{(\rho_{i0} - \rho_{i2})(\rho_{i0} - \rho_{i1}e^{j\phi_1}) - (\rho_{i0} - \rho_{i1})(\rho_{i0} - \rho_{i2}e^{j\phi_2})}{(\rho_{i0} - \rho_{i2})(1 - e^{j\phi_1}) - (\rho_{i0} - \rho_{i1})(1 - e^{j\phi_2})} \quad (4)$$

$$S_{22} = \frac{(\rho_{i0} - \rho_{i1})e^{j\phi_1} - S_{11}(1 - e^{j\phi_1})}{(\rho_{i1} - \rho_{i0})} \quad (5)$$

$$S_{12}^2 = (S_{11} - \rho_{i0})(S_{22} + 1) = (S_{11} - \rho_{i1})(S_{22} + e^{j\phi_1}) = (S_{11} - \rho_{i2})(S_{22} + e^{j\phi_2}) \quad (6)$$

The sign of S_{12} is undetermined but can usually be chosen from physical reasoning—in this case positive. The S -parameters correspond to matched conditions so that S_{11} is equivalent to Γ for matched termination. For a matched adaptor $S_{11} = \Gamma$ can be measured directly, but depends on the quality of the waveguide termination, so the offset short method is often preferred.

Unfortunately, WR-284 was not available in optimum lengths so there are some limitations of the method compared to the sliding short technique. Small variations in the measured data taken

at different times were also observed, presumably due to differences in the bolted waveguide and VNA connections. This is not unexpected when adapting to different connectors where even when care is taken to make consistent connections the repeatability is on the order of ± 0.05 dB.

The form of equations 4 through 6 indicates that even small errors in the reflection coefficients can propagate into a much larger error in the calculated S -parameters. The error in calculating the S -parameters from input reflection measurements is dominated by the uncertainty in the physical line lengths since these uncertainties are much larger than the VNA measurement error. The location of the short-circuit with respect to the VNA reference plane cannot be determined exactly by physical measurement because of the coaxial-to-waveguide adaptor but only the change in physical length with respect to a reference length is required. The physical length measurements are accurate to within ± 1 mil which is much less than 0.1% error. However, the waveguide sections have a larger variation depending on the flatness and tilt of the flanges so an average of length measurements is used. In some cases the length is composed of multiple waveguides but is measured as a single section having similar error as indicated in table 1. The standard deviation of these measurements implies an uncertainty on the order of ± 3 mils in the waveguide lengths. Then the length difference from the reference would have even larger error, ± 7 mils for independent and random uncertainties. One would consider this negligible error for the waveguides used here, but the calculated S -parameters are very sensitive to the length difference used in equations 4 through 6 where ± 7 mil can produce a noticeable change in results. Rather than using a complete error analysis for each waveguide, a constant uncertainty of ± 7 mils is assumed for all the length differences to estimate the error. At the lowest test frequency the error in the load reflection coefficient is about 1.9% so that S_{11} would have an error of $\pm 5\%$. Since the other parameters depend on S_{11} the error increases to 8% for S_{22} and SWR with the largest error in S_{12} at about 10%. The SWR is typically of primary interest and the results presented would have an error at least $\pm 8\%$ or ± 0.7 dB.

Table 1. WR-284 Waveguide lengths used in the offset short method.

	1st Section (in)	2nd Section (in)	Total Physical Length (in)	Total Electrical Length at 3 GHz
L_0	5.476 ± 0.003		5.476 ± 0.003	1.391
L_1	8.586 ± 0.003	2.996 ± 0.003	11.582 ± 0.003	2.942
L_2	9.96 ± 0.003	3.016 ± 0.003	12.976 ± 0.003	3.296
L_3	9.96 ± 0.003	5.476 ± 0.003	15.436 ± 0.003	3.921
L_4	13.454 ± 0.003	3.016 ± 0.003	16.470 ± 0.003	4.183

4. Results

The experimental approach is applied to air-filled WR-284 waveguide using five waveguide lengths. The ideal length differences in the offset short method are $\lambda_g/8$ and $3\lambda_g/8$ where the load reflection coefficient is a simple phase shift. Unfortunately, an arbitrary length as in the sliding short method is not always available unless custom fabricated to optimum lengths. When the length differences used are near a multiple of $\lambda_g/2$, they are not appropriate for the desired frequency range because this would give unity impedance transformation and so does not provide another independent length. For a uniform section of WR-284 S-Band waveguide propagating the TE₁₀-mode, the transmission line parameters can be readily calculated (7) neglecting the effect of losses. The different lengths of WR-284 are normalized to the guide wavelength, λ_g and the electrical lengths are compared in figure 5. The adaptor characteristics are obtained from the offset short data and presented in terms of the RL, IL, and SWR over the useable frequency range of 2.8 to 3.1 GHz. The calculated S_{11} and S_{22} are not identical but the differences (although not shown) are on the order of the estimated error. These differences can often be eliminated with small perturbations of the lengths used in the calculations believed to be due to small differences in the bolted connections.

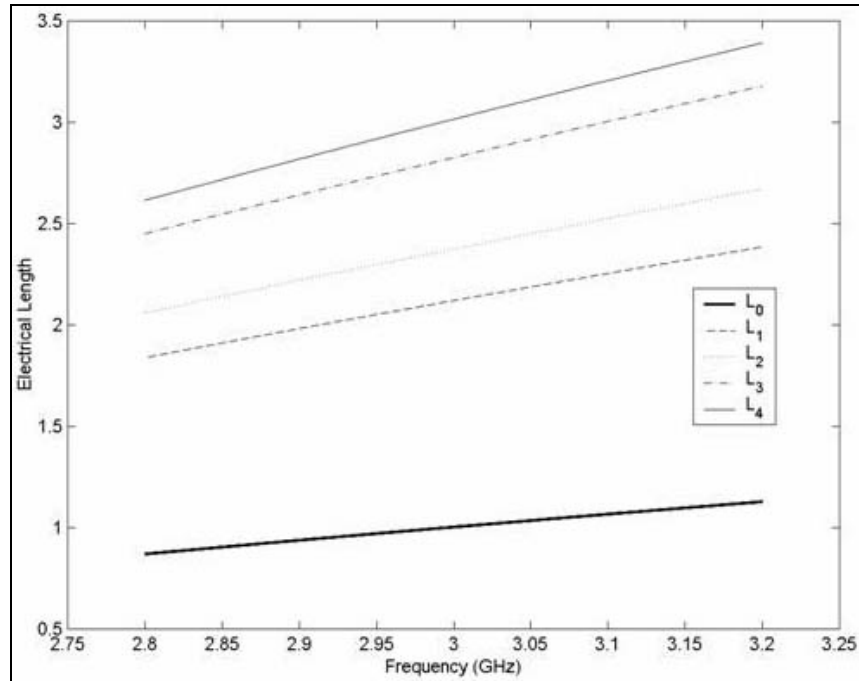


Figure 5. Electrical length of WR-284 waveguide sections.

4.1 FXR Model S601A

Serial number 154 of this type adaptor, which uses a coaxial probe without dielectric sheathing, was tested. With this particular adaptor an RF gasket in front of the shorting plate for L_2 and L_4 was used so these lengths are 1/8-in larger than that shown in table 1. In figure 6 (a) is the calculated RL and IL (in dB) when using L_0 as the reference length and either L_1 with L_2 or L_1 with L_3 . The corresponding SWR is shown in figure 6 (b) when L_0 is the reference length and includes a third result when using L_2 and L_3 . The three results in figure 6 (b) are all different but should be quite similar if not identical for the same adaptor. The discrepancy is probably because the length L_0 is so short it places the termination within a few wavelengths of the adaptor. Better results are obtained when using L_1 as the reference length as shown in figure 7 (a) where now the RL is consistent although not identical. The corresponding SWR is shown in figure 7 (b) when L_1 is the reference length. When using both L_2 and L_3 the SWR is inconsistent with the previous results. In fact, inconsistent results were obtained whenever L_2 and L_3 were used in combination as shown in figure 8 in terms of the calculated SWR. Rejecting the data obtained with L_0 and combinations of both L_2 and L_3 leaves the results when using L_1 , L_3 , and L_4 . This result (see figure 7) is marginal for many applications and better performance can often be obtained with dielectric sheathed probes (8).

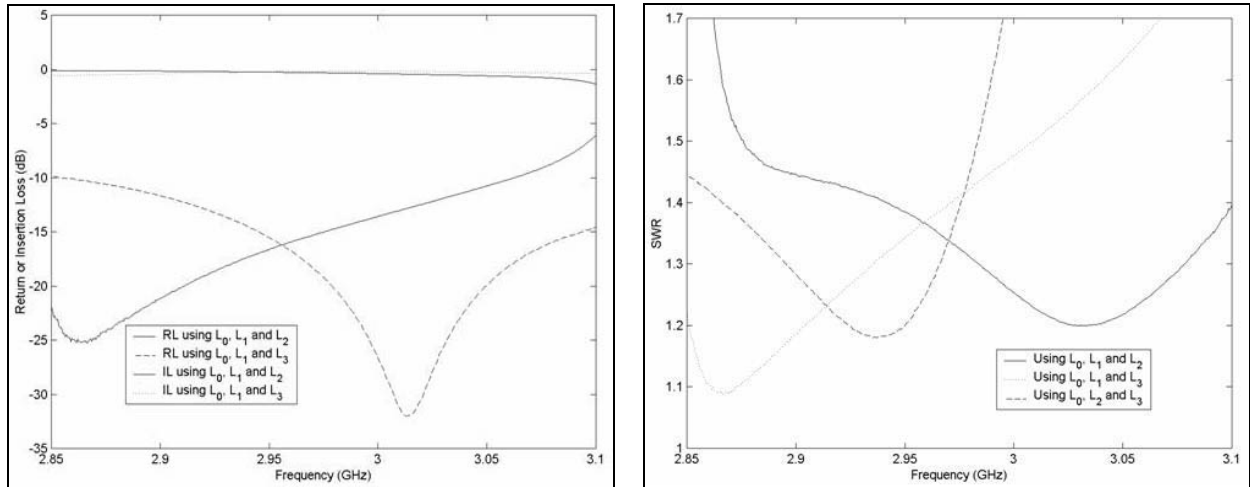


Figure 6. (a) Return and insertion loss obtained for the FXR601A adaptor when using L_0 as the reference length.
(b) Standing Wave Ratio obtained for the FXR601A adaptor when using L_0 as the reference length.

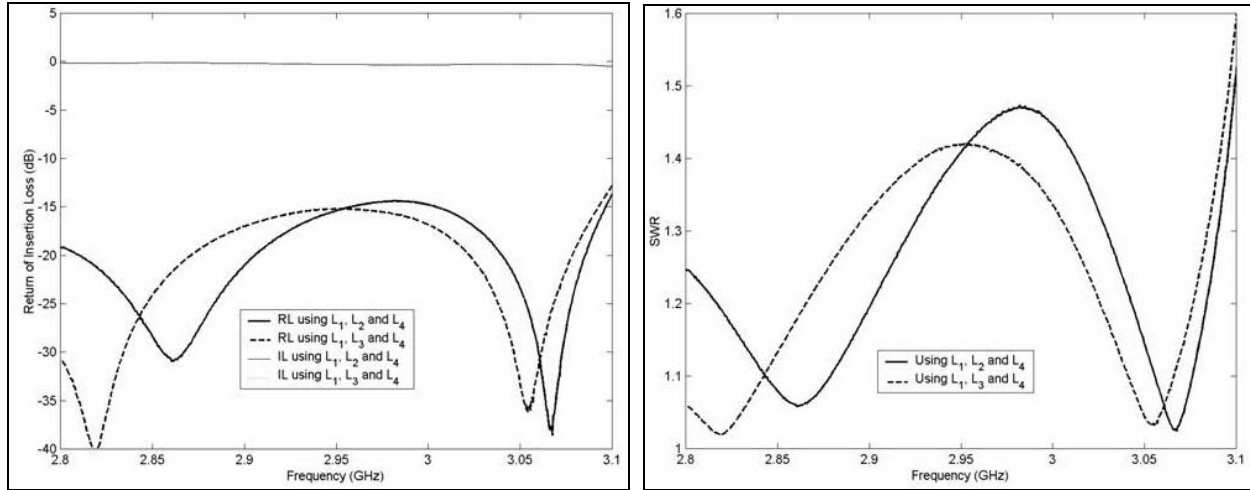


Figure 7. (a) Return and insertion loss obtained for the FXR601A adaptor when using L_1 as the reference length. (b) Standing Wave Ratio obtained for the FXR601A adaptor when using L_1 as the reference length.

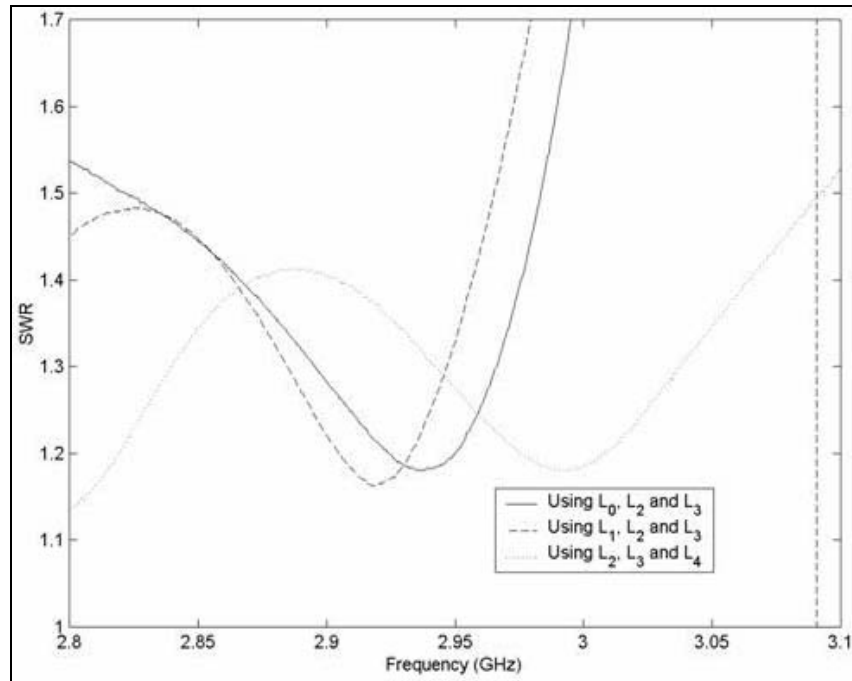


Figure 8. Standing Wave Ratio obtained for the FXR601A adaptor when using both L_2 and L_3 .

4.2 FXR Model S601B

A supposedly matched set of the S601B adaptors was available without serial numbers so they are designated parts 1 and 2. Using L_2 and L_3 in combination and using L_0 as a reference length should be avoided so only L_1 , L_3 , and L_4 are used hereafter. In figure 9 (a) the calculated RL and IL for the FXR S601B adaptors are compared. The plots are slightly different but have consistent appearance such as the expected minimum near 3 GHz. The SWR results for these

two adaptors are compared in figure 9 (b) and the results indicate they are not identical. There are some obvious differences in these two adaptors where number 1 has a dented corner and number 2 has a slightly bent connector and discoloration of the dielectric sheath due to high power operation. Even so adaptor number 2 has better characteristics over the measured band implying that the dented corner is a larger degradation on performance. The Model S601B adaptor is similar to the S601A near 3 GHz but has lower SWR at frequencies below 3 GHz. This is probably an advantage of the dielectric sheath used in the S601B adaptor and for most applications it would be preferred over the Model S601A.

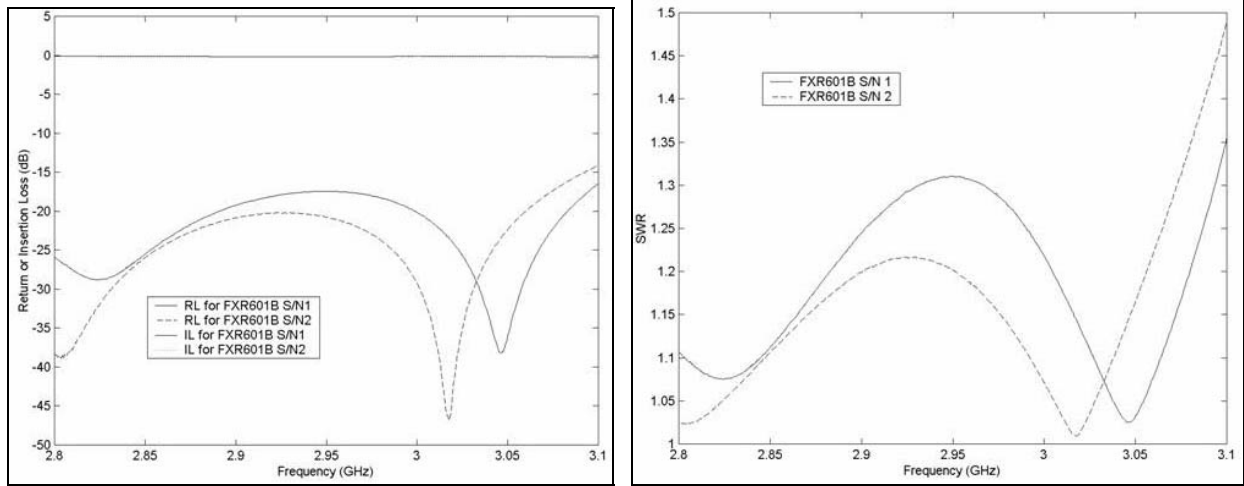


Figure 9. (a) Return and insertion loss obtained for the FXR601B adaptors using waveguide lengths L_1 , L_3 , and L_4 .
(b) Standing Wave Ratio obtained for the FXR601B adaptors using waveguide lengths L_1 , L_3 , and L_4 .

4.3 Narda Model 614A and HP Model S281A

Serial number 2506 of the Narda adaptor, which uses a dielectric sheathed probe, was the shortest of all the adaptors tested. Serial number 12038 of the HP adaptor also uses a coaxial probe with dielectric sheathing. In both cases only L_1 , L_3 , and L_4 are used for the offset short measurements. In figure 10 (a) the calculated RL and IL for these two adaptors are compared. The plots are slightly different but have consistent appearance such as the expected minimum near 3 GHz. The SWR results for these two adaptors are shown in figure 10 (b) and the results indicate they are not similar enough to be considered identical.

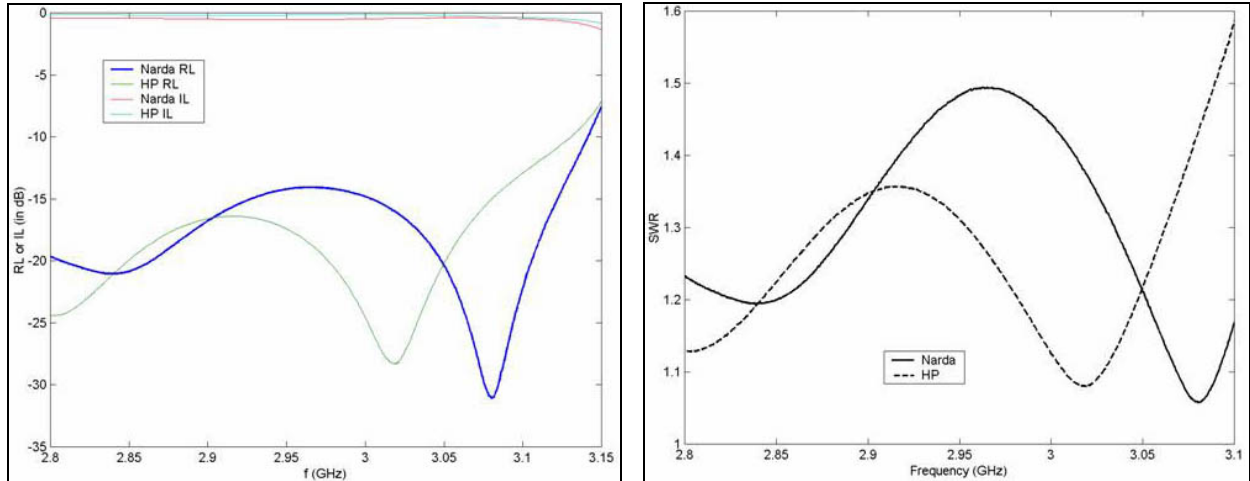


Figure 10. (a) Return and insertion loss obtained for the Narda and HP adaptors using waveguide lengths L_1 , L_3 , and L_4 . (b) Standing Wave Ratio obtained for the Narda and HP adaptors using waveguide lengths L_1 , L_3 , and L_4 .

5. Summary

The offset short method can be difficult to implement in the general case without having optimum transmission line lengths. Using sections of bolted waveguide to characterize the adaptors caused the length uncertainty to be larger than desired. This could be reduced by using custom waveguide lengths with bolted flanges only at the input and output. The results are consistent with published designs for coaxial-to-waveguide adaptors where there may be unusable notches in the specified bandwidth and in many cases an $\text{SWR} < 1.4$ is acceptable (9). A given design can often be improved with tuning posts to reduce the input reflection corresponding to $\text{RL} \sim -30$ dB, but there can still be significant variation over the operating frequency band (10). The SWR for all the adaptors tested is summarized in figure 11 over a narrower frequency range, 2.9 to 3.1 GHz. The Narda adaptor appears to be least desirable while the FXR 601B (S/N 2) has the best performance for many applications at 3 GHz. The FXR 601B adaptors are similar but could not be considered identical. The closest match of the adaptors tested are the HP and FXR601B (S/N 2) adaptors but again these parts are not identical. Of the available S-Band adaptors, these two will be used for characterization of the dual-ridged waveguide experimental fixture and the evaluation of the slitted waveguide as a leaky wave antenna. Although the available WR-284 components are not ideal, most of the adaptors are sufficient for research purposes. Other researchers can use the measurements on these adaptors to pick the part most suitable for a given application.

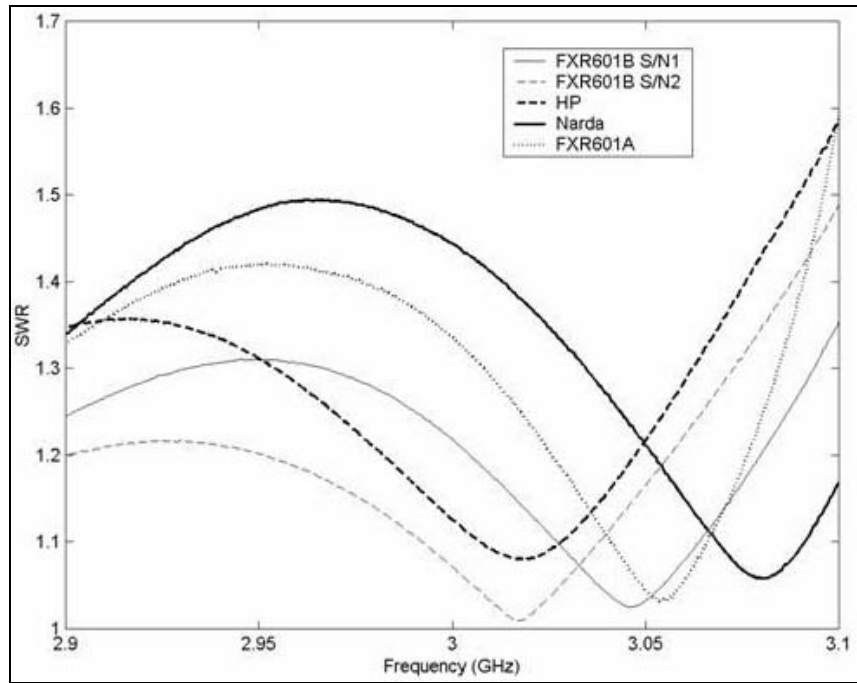


Figure 11. Standing Wave Ratio obtained for microwave adaptors using waveguide lengths L_1 , L_3 , and L_4 .

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